

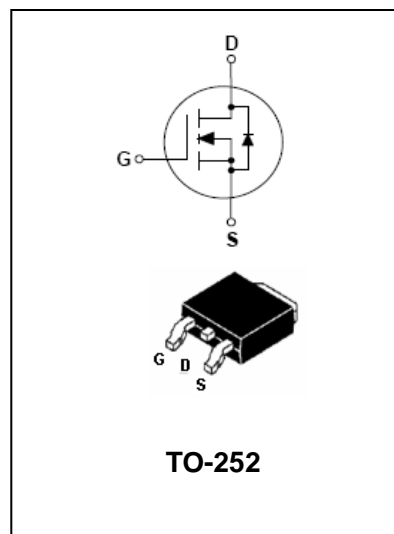
N-Channel Enhancement Mode MOSFET

BL6N40D

FEATURES

- $R_{DS(ON)} = 1.0\Omega @ V_{GS} = 10V$
- Fast switching speed
- Improved dv/dt capability

HF



Ordering Information

| Part Number | Package | Shipping | Marking Code |
|-------------|---------|---------------------------------------|--------------|
| BL6N40D | TO-252 | 80pcs / Tube or 2500pcs / Tape & Reel | 6N40D |

MAXIMUM RATING operating temperature range applies unless otherwise specified

| Symbol | Parameter | Value | Units |
|-----------------|--|-------------|---------------|
| V_{DS} | Drain-Source voltage | 400 | V |
| V_{GS} | Gate -Source voltage | ± 30 | V |
| I_D | Continuous Drain current ^(Note5) | 6 | A |
| I_{DM} | Pulsed Drain current ^(Note5) | 24 | A |
| E_{AS} | Single Pulse Avalanche Energy ^(Note3) | 330 | mJ |
| E_{AR} | Avalanche Energy, Repetitive ^(Note2) | 8.5 | mJ |
| I_{AR} | Avalanche Current ^(Note2) | 6 | A |
| dv/dt | Peak Diode Recovery dv/dt ^(Note4) | 4.5 | V/ns |
| P_D | Power Dissipation | 62.5 | W |
| $R_{\theta JC}$ | Junction-to-Case | 2 | $^{\circ}C/W$ |
| $R_{\theta JA}$ | Junction-to-Ambient | 110 | $^{\circ}C/W$ |
| T_J, T_{stg} | Junction and Storage Temperature | -55 to +150 | $^{\circ}C$ |

Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

3. $L=19mH, I_{AS}=5.5A, V_{DD}=50V, R_G=25\Omega$, Starting $T_J = 25^{\circ}C$.

4. $I_{SD} \leq 6A, di/dt \leq 200A/\mu s, V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^{\circ}C$.

5. Drain current limited by maximum junction temperature.

N-Channel Enhancement Mode MOSFET

BL6N40D

ELECTRICAL CHARACTERISTICS

| Parameter | Symbol | Test conditions | MIN | TYP | MAX | UNIT |
|---|--------------------------------------|--|-----|------|-----------|----------|
| Drain-Source Breakdown Voltage | $V_{(BR)DSS}$ | $V_{GS}=0V, I_D=250\mu A$ | 400 | - | - | V |
| Bvdss Temperature Coefficient | $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | $I_D=250\mu A$ | - | 0.54 | - | V/°C |
| Gate Threshold Voltage | $V_{GS(TH)}$ | $V_{DS}=V_{GS}, I_D=250\mu A$ | 2 | | 4 | V |
| Drain to Source Leakage Current | I_{DSS} | $V_{DS}=400V, V_{GS}=0V$ | - | - | 1 | μA |
| Static drain-Source on-resistance | $R_{DS(ON)}$ | $V_{GS}=10V, I_D=3A$ | - | 0.78 | 1 | Ω |
| Gate-body Leakage Forward Reverse | I_{GSS} | $V_{GS}=\pm 30V$ | - | - | ± 100 | nA |
| Input Capacitance | C_{iss} | $V_{GS}=0V, V_{DS}=25V$ $f=1.0MHz$ | - | 480 | 625- | pF |
| Output Capacitance | C_{oss} | | - | 80 | 105 | |
| Reverse Transfer Capacitance | C_{rss} | | - | 15 | 20 | |
| Turn-on Delay Time | $t_{d(ON)}$ | $I_D=6A, V_{DD}=200V$ $R_G=25\Omega$ (Note1,2) | - | 13 | 35 | ns |
| Rise Time | t_r | | - | 65 | 140 | |
| Turn-Off Delay Time | $t_{d(OFF)}$ | | - | 21 | 55 | |
| Fall Time | t_f | | - | 38 | 85 | |
| Total Gate Charge | Q_g | $I_D=6A, V_{DS}=320V$ $V_{GS}=10V$ (Note1,2) | - | 16 | 20 | nC |
| Gate to Source Charge | Q_{gs} | | - | 2.3 | - | |
| Gate to Drain ("Miller") Charge | Q_{gd} | | - | 8.2 | - | |
| Reverse Recovery Time | t_{rr} | $I_S=6A, T_J=25^\circ C$ $dI_F/dt=100A/\mu s$ (Note1), $V_{GS}=0V$ | - | 230 | - | ns |
| Reverse Recovery Charge | Q_{rr} | | - | 1.7 | - | nC |

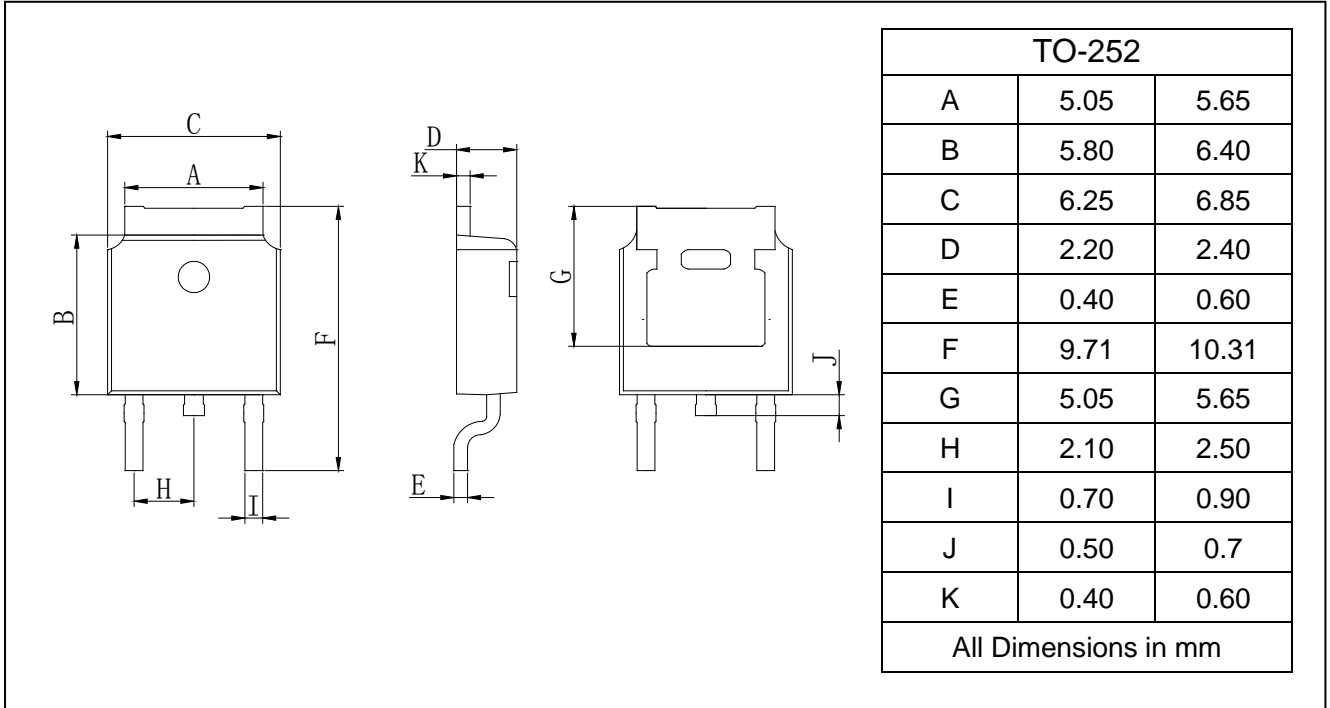
N-Channel Enhancement Mode MOSFET

BL6N40D

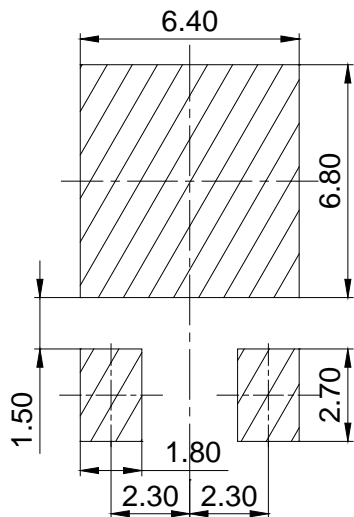
PACKAGE OUTLINE

Plastic surface mounted package

TO-252



SOLDERING FOOTPRINT



Unit: mm